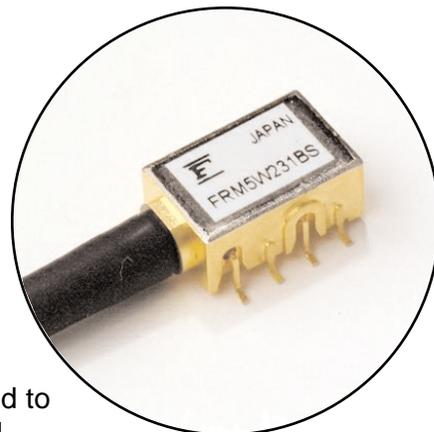


## FEATURES

- 2.5Gb/s APD Receiver module in industry standard mini-DIL package
- -34 dBm Sensitivity (Typ.)
- -4 dBm Overload (Typ.)
- Integral Thermistor
- Integral GaAs IC Preamp
- Differential Electrical Output



## APPLICATIONS

This 40 GHz gain bandwidth product APD detector preamp is intended to function as an optical receiver in long haul SONET, SDH, and DWDM systems operating at 2.5 Gb/s. The device operates in both the 1,310 and 1,550nm wavelength windows. The nominal 10K $\Omega$  integral thermistor allows accurate monitoring of the APD temperature and facilitates the design of the APD bias control circuits. The detector preamplifier is DC coupled with a differential electrical output.

## DESCRIPTION

The FRM5W231BS incorporates a 30 micron InGaAs Avalanche Photodiode (APD) detector, a GaAs IC transimpedance preamplifier, and a thermistor in a mini-dil type package. The APD is processed with modern MOVPE techniques resulting in reliable performance over a wide range of operating conditions. The lens coupling system and the single mode fiber are assembled using Nd: YAG welding techniques.

## ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Storage Temperature	T <sub>stg</sub>	-40 to +85	°C
Operating Case Temperature	T <sub>op</sub>	-40 to +85	°C
Supply Voltage	V <sub>DD</sub>	0 to +6.5	V
APD Reverse Voltage	V <sub>R</sub>	0 to V <sub>B</sub>	V
APD Reverse Current	I <sub>R</sub> (Peak)	2	mA

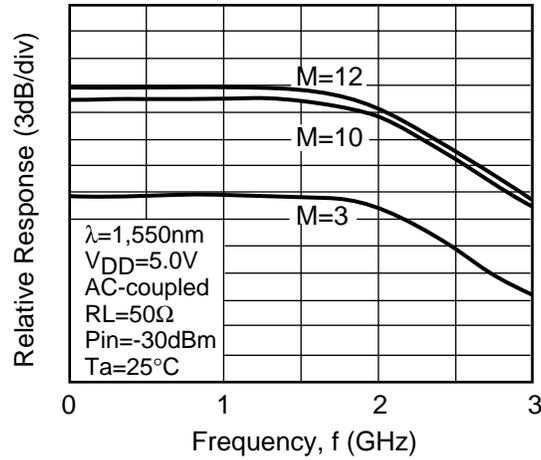
## OPTICAL &amp; ELECTRICAL CHARACTERISTICS

(T<sub>C</sub>=25°C, λ=1.31/1.55μm, V<sub>DD</sub>=+5.0V unless otherwise specified)

Parameter	Symbol	Test Conditions	Limits			Unit
			Min.	Typ.	Max.	
APD Responsivity	R13	1,310nm, M=1	0.75	0.85	-	A/W
	R15	1,550nm, M=1	0.80	0.85	-	
APD Breakdown Voltage	V <sub>B</sub>	I <sub>D</sub> =10μA	40	50	65	V
Temperature Coefficient of V <sub>B</sub>	Γ	(Note 2)	0.08	0.12	0.15	V/°C
AC Transimpedance	Z <sub>t</sub>	AC-Coupled, f=100MHz, RL=50Ω	-	2.0	-	kΩ
Bandwidth	BW	AC-Coupled, RL=50Ω, M=10, -3dBm from 1MHz	1.8	2.0	-	GHz
Equivalent Input Noise Current	i <sub>n</sub>	AC-Coupled, RL=50Ω, Average in BW	-	8.0	9.0	pA/√Hz
Sensitivity	P <sub>r</sub>	2.488Gb/s, NRZ, PRBS=2 <sup>23</sup> -1, B.E.R.=10 <sup>-10</sup> , Rext=13dB, VR is set at optimum value. Tc=25°C	-	-34.0	-32.0	dBm
		Tc=-40 to +85°C	-	-33.0	-31.0	
Maximum Overload	P <sub>o1</sub>	(Note 3)	-7	-6	-	dBm
	P <sub>o2</sub>	(Note 4)	-5	-4	-	
Optical Return Loss	ORL		30	-	-	dB
Power Supply Current	I <sub>DD</sub>		-	-	70	mA
Power Supply Voltage	V <sub>DD</sub>		4.75	5.0	5.25	V
Thermistor Resistance	R <sub>th</sub>		9.5	10.0	10.5	kΩ
Thermistor B Constant	B		3800	3900	4000	K

Note: (1) Since V<sub>B</sub> may vary from device to device, V<sub>B</sub> data is attached to each device for reference.(2)  $\Gamma = \Delta V_B / \Delta T_C$ .(3) P<sub>o1</sub> is defined by 10% distortion of the output waveform on the ground level in an AC-coupling condition at a multiplication factor (M) is 3.(4) P<sub>o2</sub> is defined as the maximum overload where the BER of 10<sup>-10</sup> is maintained by changing only the VR condition to obtain M=3. The other conditions are the same as those of minimum sensitivity.

**Fig. 1 APD Detector-Preamp response as a function of frequency with multiplication level as a parameter.**



**Fig. 2 Bit Error Rate at 1,550nm and a 2.488 Gb/s NRZ  $2^{23-1}$  PRBS for various case temperatures.**

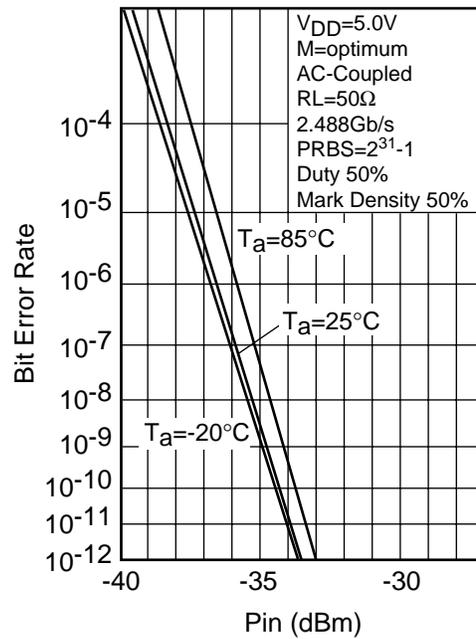


Fig. 3 Output Wave Form  $T_c=25^\circ\text{C}$ ,  $R_L=50\Omega$ ,  
 $P_{in}=-30\text{dBm}$ ,  $V_{DD}=5.0\text{V}$ ,  $M=12$

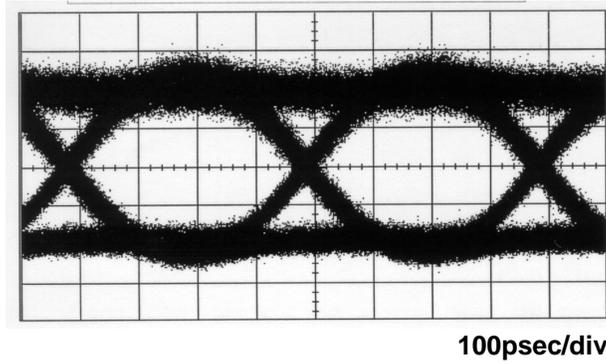
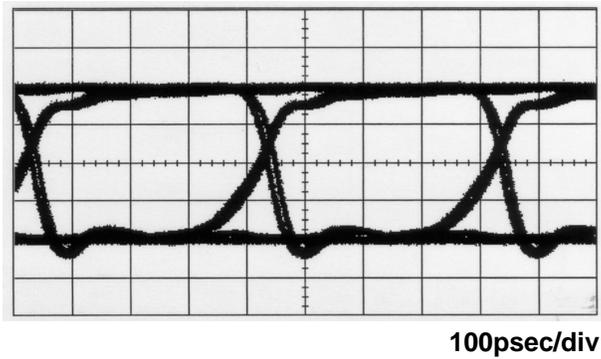
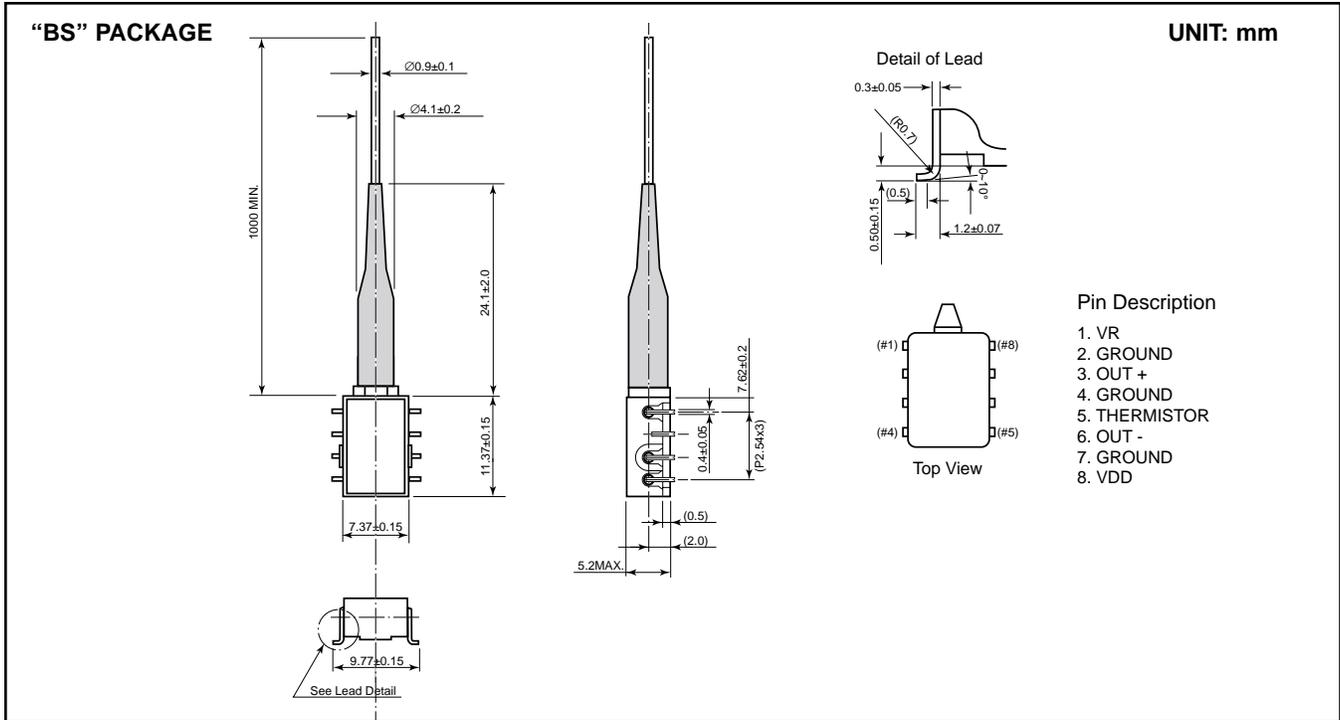


Fig. 4 Output Wave Form  $T_c=25^\circ\text{C}$ ,  $R_L=50\Omega$   
 $P_{in}=-7\text{dBm}$ ,  $V_{DD}=5.2\text{V}$ ,  $M=3$





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